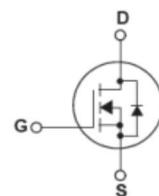


1500V N-Channel MOSFET

General Description

This Power MOSFET is produced using advanced planar stripe DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.



Features

9A, 1500V, $R_{DS(on)}$ typ. = 2.6Ω @ $V_{GS} = 10\text{ V}$

Advanced planar process

Low gate charge minimize switching loss

Fast switching

100% avalanche tested

Improved dv/dt capability

Absolute Maximum Ratings $T_c = 25\text{ }^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | | JFHM9N150E | Units |
|----------------|--|--|-------------|---------------------|
| V_{DSS} | Drain – Source Voltage | | 1500 | V |
| I_D | Drain Current | Continuous ($T_c = 25\text{ }^\circ\text{C}$) | 9* | A |
| | | Continuous ($T_c = 100\text{ }^\circ\text{C}$) | 5* | A |
| I_{DM} | Drain Current - Pulsed (Note 1) | | 36 | A |
| V_{GSS} | Gate – Source Voltage | | ± 30 | V |
| EAS | Single Pulsed Avalanche Energy (Note 2) | | 420 | mJ |
| I_{AR} | Avalanche Current (Note 1) | | 9 | A |
| dv/dt | Peak Diode Recovery dv/dt (Note 3) | | 50 | V/ns |
| P_D | Power Dissipation ($T_c = 25\text{ }^\circ\text{C}$) -Derate above $25\text{ }^\circ\text{C}$ | | 277 | W |
| | | | 2.22 | W/ $^\circ\text{C}$ |
| T_J, T_{STG} | Operating and Storage Temperature Range | | -55 to +150 | $^\circ\text{C}$ |
| T_L | Maximum lead temperature for soldering purposes 1/8" from case for 5 seconds | | 300 | $^\circ\text{C}$ |

*Drain current limited by maximum junction temperature.

Thermal characteristics

| Symbol | Parameter | JFHM9N150E | | | Units |
|----------------|---|------------|--|--|-------|
| R_{\thetaJC} | Thermal Resistance, Junction-to-Case | 0.45 | | | °C/W |
| R_{\thetaJA} | Thermal Resistance, Junction-to-Ambient | 50 | | | °C/W |

Electrical Characteristics $T_c = 25^\circ C$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|---|---|---|------|------|------|-------|
| Off Characteristics | | | | | | |
| BV_{DSS} | Drain – Source Breakdown Voltage | $V_{GS} = 0 V, I_D = 250 \mu A$ | 1500 | -- | -- | V |
| $\Delta BV_{DSS}/\Delta T_J$ | Breakdown Voltage Temperature Coefficient | $I_D = 250 \mu A$, Referenced to $25^\circ C$ | -- | 0.5 | -- | V/°C |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 1500 V, V_{GS} = 0 V$ | -- | -- | 1 | uA |
| | | $V_{DS} = 1200 V, T_c = 125^\circ C$ | -- | -- | 10 | uA |
| I_{GSSF} | Gate-Body Leakage Current, Forward | $V_{GS} = 30 V, V_{DS} = 0 V$ | -- | -- | 100 | nA |
| I_{GSSR} | Gate-Body Leakage Current, Reverse | $V_{GS} = -30 V, V_{DS} = 0 V$ | -- | -- | -100 | nA |
| On Characteristics | | | | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = 250 \mu A$ | 2.5 | -- | 4.5 | V |
| $R_{DS(on)}$ | Static Drain-Source on-Resistance | $V_{GS} = 10 V, I_D = 4.5 A$ | -- | 2.6 | 3.5 | Ω |
| g_{FS} | Forward Transconductance | $V_{DS} = 40 V, I_D = 9 A$ (Note 4) | -- | 10 | -- | S |
| Dynamic Characteristics | | | | | | |
| C_{iss} | Input Capacitance | $V_{DS} = 25 V, V_{GS} = 0 V, f = 1.0 \text{ MHz}$ | -- | 3187 | -- | pF |
| C_{oss} | Output Capacitance | | -- | 309 | -- | pF |
| C_{rss} | Reverse Transfer Capacitance | | -- | 17.5 | -- | pF |
| Switching Characteristics | | | | | | |
| $t_{d(on)}$ | Turn-On Delay Time | $V_{DS} = 750 V, I_D = 9.0 A, R_G = 25\Omega, V_{GS} = 10 V$ (Note 4,5) | -- | 70 | -- | ns |
| t_r | Turn-On Rise Time | | -- | 191 | -- | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | -- | 82 | -- | ns |
| t_f | Turn-Off Fall Time | | -- | 114 | -- | ns |
| Q_g | Total Gate Charge | | -- | 90 | -- | nC |
| Q_{gs} | Gate-Source Charge | $V_{DS} = 750 V, I_D = 9.0 A, V_{GS} = 10 V$ (Note 4,5) | -- | 18 | -- | nC |
| Q_{gd} | Gate-Drain Charge | | -- | 46 | -- | nC |
| Drain – Source Diode Characteristics and Maximum Ratings | | | | | | |
| I_S | Maximum Continuous Drain-Source Diode Forward Current | -- | -- | 9 | A | |
| I_{SM} | Maximum Pulsed Drain-Source Diode Forward Current | -- | -- | 36 | A | |
| V_{SD} | Drain-Source Diode Forward Voltage | $V_{GS} = 0 V, I_S = 9.0 A$ | -- | -- | 1.4 | V |
| t_{rr} | Reverse Recovery Time | $V_{GS} = 0 V, I_S = 9.0 A$ | -- | 460 | -- | ns |
| Q_{rr} | Reverse Recovery Charge | $dI_F/dt = 100 A/\mu s$ (Note 4) | -- | 3.31 | -- | uC |

Notes:

- Repetitive Rating : Pulsed width limited by maximum junction temperature
- $L = 10mH, I_{AS} = 9A, V_{DD} = 50V, R_G = 25\Omega$, Starting $T_J = 25^\circ C$
- $I_{SD} \leq 9.0A, dI/dt \leq 200A/\mu s, V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ C$
- Pulsed Test : Pulsed width $\leq 300\mu s$, Duty cycle $\leq 2\%$
- Essentially independent of operating temperature



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JFHM9N150E

Typical Characteristics

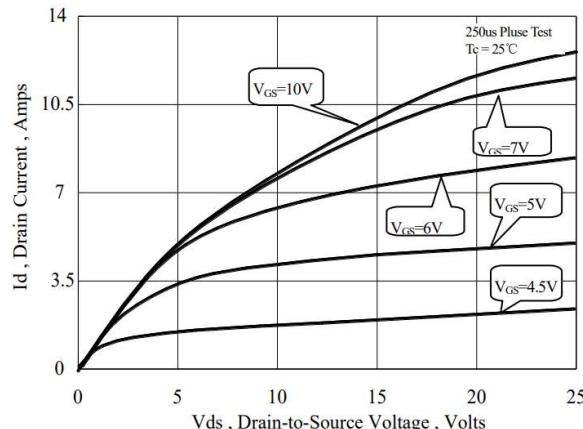


Figure 1. On-Region Characteristics

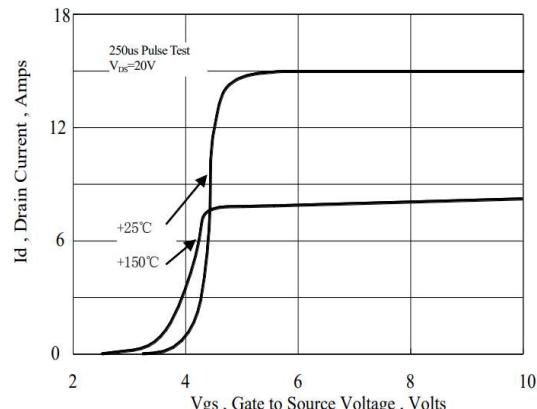


Figure 2. Transfer Characteristics

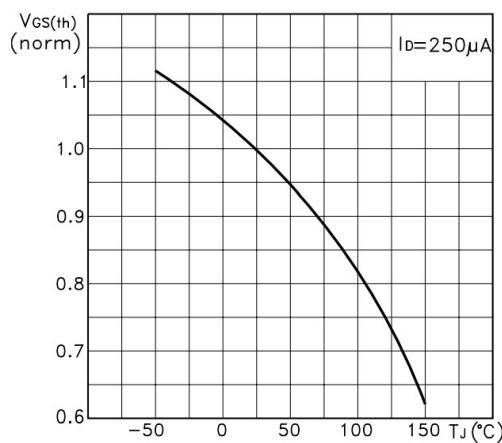


Figure 3. Gate Voltage vs Temperature

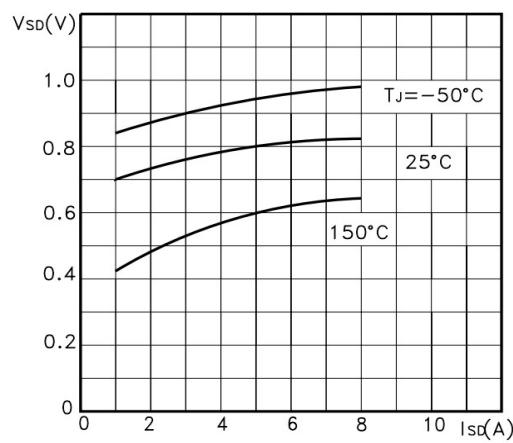


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

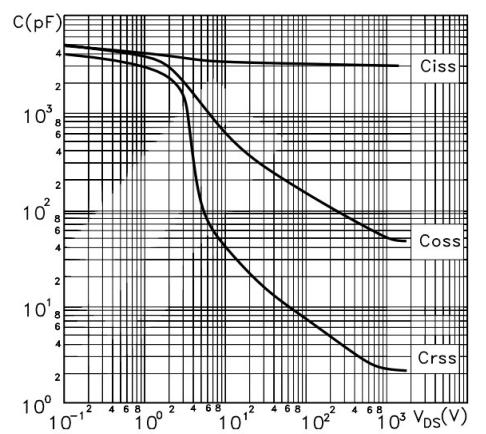


Figure 5. Capacitance Characteristics

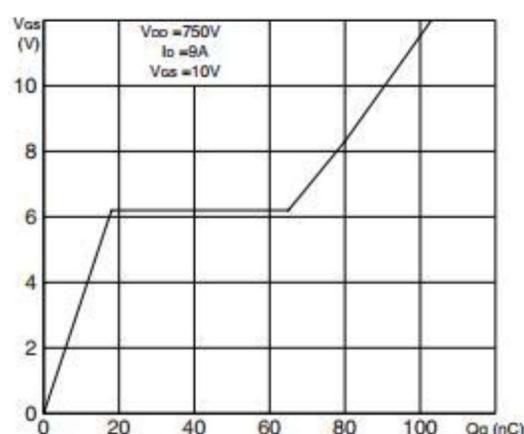


Figure 6. Gate Charge Characteristics



Typical Characteristics

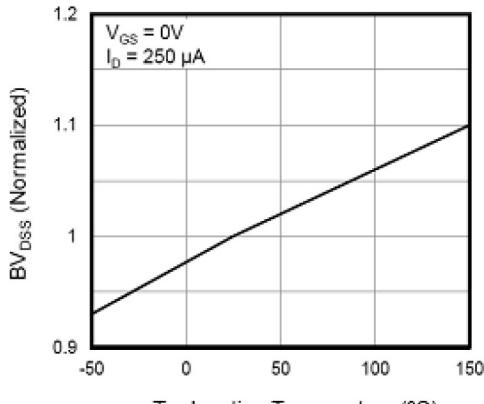


Figure 7. Breakdown Voltage Variation
vs Temperature

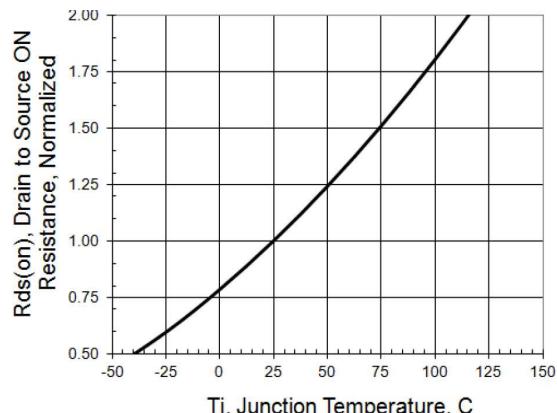


Figure 8. On-Resistance Variation
vs Temperature

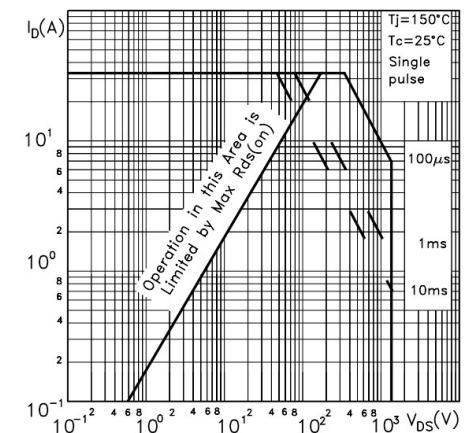


Figure 9. Maximum Safe Operating Area
for JFHM9N150E

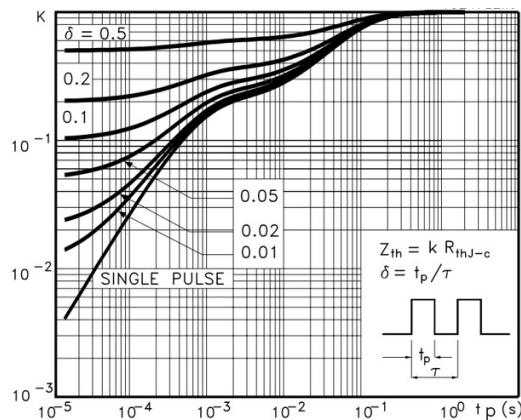
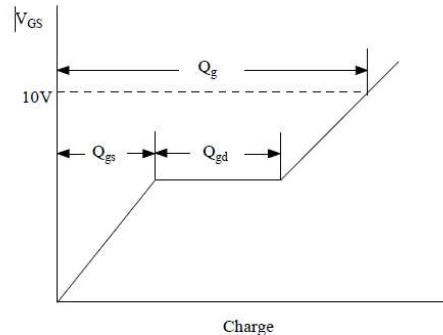
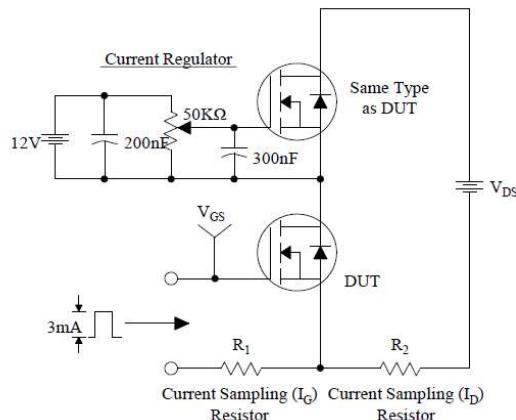


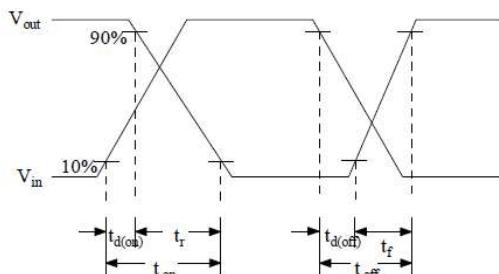
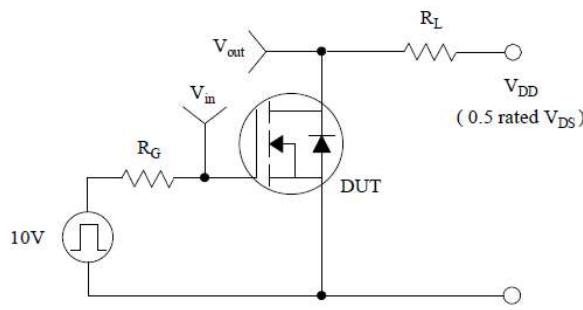
Figure 10. Transient Thermal Response Curve for
JFHM9N150E



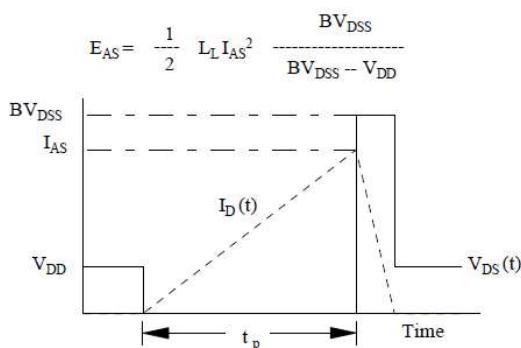
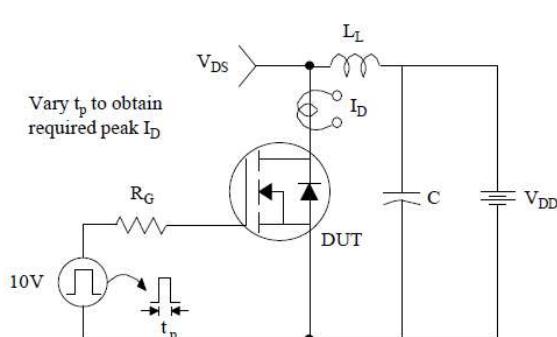
Test Circuit & Waveform



Gate Charge Test Circuit & Waveform



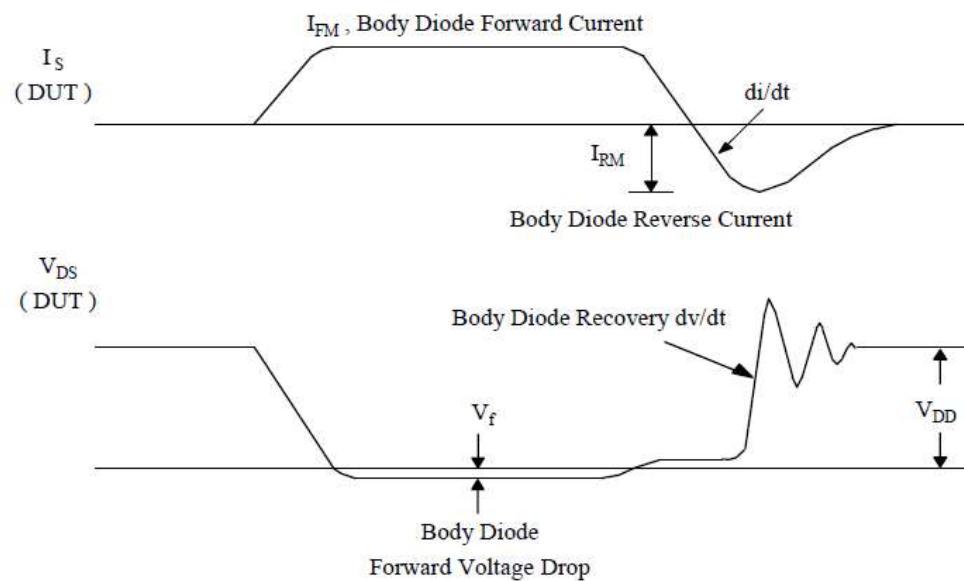
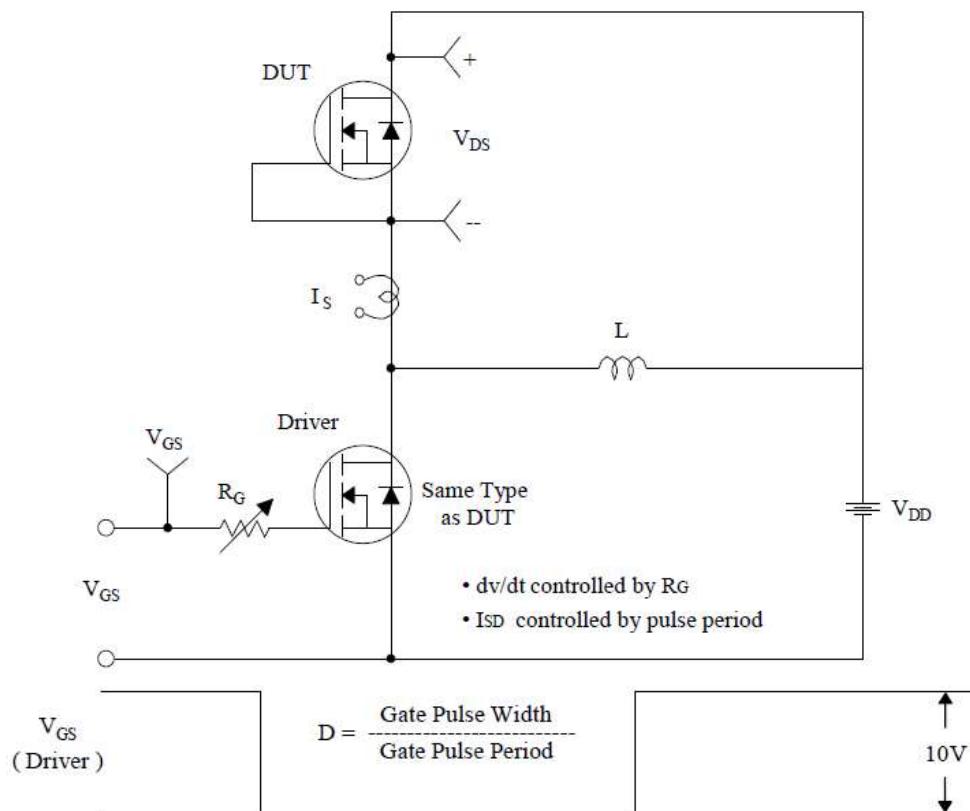
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms



Test Circuit & Waveform



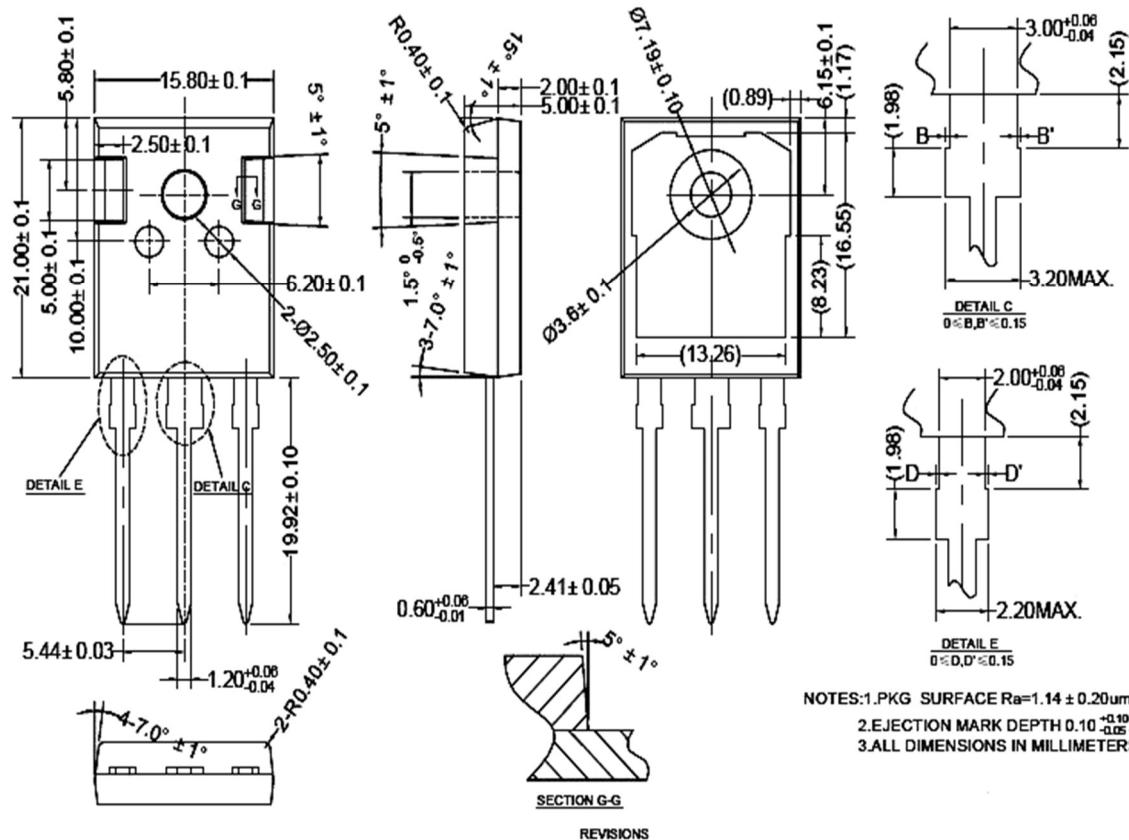
Peak Diode Recovery dv/dt Test Circuit & Waveforms



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JFHM9N150E

Package



| 公差标注 | 公差值 | 表面粗糙度 |
|--------|--------|-----------|
| 0 | ±0.2 | Ra3.2~6.3 |
| 0.0 | ±0.1 | Ra1.6~3.2 |
| 0.00 | ±0.01 | Ra0.8~1.6 |
| 0.000 | ±0.005 | Ra0.4~0.8 |
| 0.0000 | ±0.002 | Ra0.2~0.4 |

NOTES:
1.PKG SURFACE Ra=1.14 ± 0.20 μm.
2.EJECTION MARK DEPTH 0.10^{+0.10}/_{-0.05}.
3.ALL DIMENSIONS IN MILLIMETERS.

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